Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/678,129	ITABASHI ET AL.
Examiner	**Art Unit**
Y. J. Han	2838

SEARCHED			
Class	Subclass	Date	Examiner
323	222		
	224		
	225		
	266		
	271		
	284		
	285		
363	55	6/05	YA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR